Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10541906	FINCH ET AL.
Examiner	Art Unit
Barker, Matthew	3662

SEARCHED				
Class	Subclass	Date	Examiner	
342	157.2,194,	12/21/2006	Hien Le	
342	163,159-164	8/9/2007	Hien Ly	
342	160	6/12/2008	MMB	
	updated	1/2/2009	MMB	

SEARCH NOTES			
Search Notes	Date	Examiner	
Inventor's name search	12/20/2006	Hien Ly	
NPL search	12/20/2006	Hien Ly	
Plus search	12/20/2006	Hien Ly	
Text search	12/20/2006	Hien ly	
NPL search (update)	8/8/2007	Hien ly	
Text search (update)	8/8/2007	Hien Ly	
342/104, 105, 109, 115, 194, 195, 161, 162, 164 - test search, see printoutx	6/12/2008	MMB	
EAST text search - see printout	6/13/2008	MMB	
Updated text search - see printout	1/2/2009	MMB	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examine

U.S. Patent and Trademark Office Part of Paper No. :